Reexamination 10/563,416 DEKKER ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1

Ori Nadav 2811

Applicant(s)/Patent Under

II S PATENT DOCUMENTS

Application/Control No.

U.S. PATENT DOCUMENTS							
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification		
*	Α	US-6,607,135	08-2003	Hirai et al.	235/487		
*	В	US-7,059,534	06-2006	Takahashi, Hideki	235/492		
	С	US-					
	D	US-					
	Е	US-					
	F	US-					
	G	US-		-			
	Н	US-		-			
	Т	US-					
	J	US-					
	к	US-					
	L	US-					
	М	US-					

FOREIGN PATENT DOCUMENTS

	T THE TOTAL THE TOTAL TO								
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification			
	N								
	0								
	Р								
	Q								
	R								
	s								
	Т								

NON-PATENT DOCUMENTS						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	v					
	w					
	×					

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.